







CD54HC259, CD74HC259, CD54HCT259, CD74HCT259 SCHS173D - NOVEMBER 1997 - REVISED NOVEMBER 2021

CDx4HC(T)259 High-Speed SMOS Logic 8-Bit Addressable Latch

1 Features

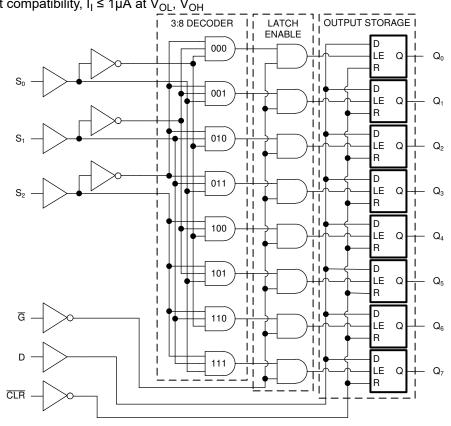
- Buffered inputs and outputs
- Four operating modes
- Typical propagation delay of 15ns at V_{CC} = 5V, C_{L} = 15pF, T_A = 25°C
- Fanout (over temperature range)
 - Standard Outputs: 10 LSTTL loads
 - _ Bus driver outputs: 15 LSTTL loads
- Wide operating temperature range: -55°C to 125°C
- Balanced propagation delay and transition times •
- Significant power reduction compared to LSTTL • logic ICs
- HC types ٠
 - 2 V to 6 V operation
 - High noise immunity: $N_{IL} = 30\%$, $N_{IH} = 30\%$ of V_{CC} at V_{CC} = 5 V
- HCT types
 - 4.5 V to 5.5 V operation
 - Direct LSTTL input logic compatability, V_{IL} = 0.8 V (max), V_{IH} = 2 V (min)
 - CMOS input compatibility, $I_I \le 1\mu A$ at V_{OL} , V_{OH}

2 Description

The CDx4HC(T)259 is an 8-bit addressable latch with three active modes of operation (addressable latch, memory, 8-line demultiplexer) and one reset mode.

Device Information							
PART NUMBER	PACKAGE ⁽¹⁾	BODY SIZE (NOM)					
CD54HC259F3A	CDIP (16)	21.34 mm × 6.92 mm					
CD54HCT259F3A	CDIP (16)	21.34 mm × 6.92 mm					
CD74HC259E	PDIP (16)	19.31 mm × 6.35 mm					
CD74HCT259E	PDIP (16)	19.31 mm × 6.35 mm					
CD74HC259M	SOIC (16)	9.90 mm × 3.90 mm					
CD74HCT259M	SOIC (16)	9.90 mm × 3.90 mm					

(1) For all packages see the orderable addendum at the end of the data sheet



Functional Block Diagram





Table of Contents

1 Features1	7.2 Functional Block Diagram10
2 Description1	7.3 Device Functional Modes11
3 Revision History	8 Power Supply Recommendations12
4 Pin Configuration and Functions	9 Layout
5 Specifications	9.1 Layout Guidelines12
5.1 Absolute Maximum Ratings4	10 Device and Documentation Support13
5.2 Recommended Operating Conditions4	10.1 Documentation Support13
5.3 Thermal Information4	10.2 Receiving Notification of Documentation Updates 13
5.4 Electrical Characteristics5	10.3 Support Resources13
5.5 Prerequisite for Switching Characteristics	10.4 Trademarks13
5.6 Switching Characteristics ⁽²⁾	10.5 Electrostatic Discharge Caution13
6 Parameter Measurement Information8	10.6 Glossary13
7 Detailed Description10	11 Mechanical, Packaging, and Orderable
7.1 Overview	Information13

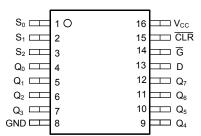
3 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Cł	nanges from Revision C (October 2003) to Revision D (November 2021)	Page
•	Updated the numbering, formatting, tables, figures, and cross-references throughout the document to re modern datasheet standards.	flect
•	Updated pin names to match current TI naming conventions. A_0 is now S_0 , A_1 is now S_1 , A_2 is now S_2	3



4 Pin Configuration and Functions



J, D or PW Package 16-Pin CDIP, SOIC or TSSOP Top View



5 Specifications

5.1 Absolute Maximum Ratings

			MIN	MAX	UNIT
V _{CC}	Supply voltage		-0.5	7	V
I _{IK}	Input clamp diode current	For $V_{I} < -0.5V$ or $V_{I} > V_{CC} + 0.5V$		±20	mA
I _{ОК}	Output clamp diode current	For V_O < -0.5V or V_O > V_{CC} + 0.5V		±20	mA
I _O	Drain current, per output	For -0.5V < V _O < V _{CC} + 0.5V		±25	mA
I _O	Output source or sink current per output pin	For V_{O} > -0.5V or V_{O} < V_{CC} + 0.5V		±25	mA
	Continuous current through	V _{CC} or GND		±50	mA
TJ	Junction temperature			150	°C
T _{stg}	Storage temperature		-65	150	°C
	Lead temperature (Soldering	g 10s) (SOIC - lead tips only)		300	°C

Over operating free-air temperature range (unless otherwise noted)⁽¹⁾

(1) Stresses beyond those listed under *absolute maximum ratings* may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under *recommended operating conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

5.2 Recommended Operating Conditions

			MIN	MAX	UNIT
V _{cc}		HC Types	2	6	V
	Supply voltage range	HCT Types		5.5	v
VI	Input voltage		0	V _{CC}	V
Vo	Output voltage		0	V _{CC}	V
		V _{CC} = 2V		1000	
tt	Input rise and fall time	V _{CC} = 4.5V		500	ns
		V _{CC} = 6V		400	
T _A	Temperature range		-55	125	°C

5.3 Thermal Information

		CD74HC259,	CD74HCT259	
		N (PDIP)	D (SOIC)	
THERMAL METRIC		16 PINS	16 PINS	UNIT
R _{θJA}	Junction-to-ambient thermal resistance ⁽¹⁾	67	73	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.



5.4 Electrical Characteristics

	PARAMETER	TEST	V AA		25°C		-40°C to	85°C	-55°C to	125°C	UNIT
FARAMETER		CONDITIONS	V _{CC} (V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNII
нс түг	PES										
			2	1.5			1.5		1.5		V
VIH	High-level input voltage		4.5	3.15			3.15		3.15		V
			6	4.2			4.2		4.2		V
			2			0.5		0.5		0.5	V
VIL	Low-level input voltage		4.5			1.35		1.35		1.35	V
			6			1.8		1.8		1.8	V
		I _{OH} = – 20 μA	2	1.9			1.9		1.9		V
	High-level output voltage	I _{OH} = – 20 μA	4.5	4.4			4.4		4.4		V
V _{ОН}		I _{OH} = – 20 μA	6	5.9			5.9		5.9		V
		I _{OH} = – 4 mA	4.5	3.98			3.84		3.7		V
	High-level output voltage	I _{OH} = – 5.2 mA	6	5.48			5.34		5.2		V
		I _{OL} = 20 μA	2			0.1		0.1		0.1	V
	Low-level output voltage	I _{OL} = 20 μA	4.5			0.1		0.1		0.1	V
V _{OL}		I _{OL} = 20 μA	6			0.1		0.1		0.1	V
	Low-level output voltage	I _{OL} = 4 mA	4.5			0.26		0.33		0.4	V
		I _{OL} = 5.2 mA	6			0.26		0.33		0.4	V
I	Input leakage current	$V_{I} = V_{CC}$ or GND	6			±0.1		±1		±1	μA
I _{cc}	Supply current	$V_{I} = V_{CC}$ or GND	6			8		80		160	μA
HCT TY	PES										
V _{IH}	High-level input voltage		4.5 to 5.5	2			2		2		V
V _{IL}	Low-level input voltage		4.5 to 5.5			0.8		0.8		0.8	V
	High-level output voltage	V _{OH} = – 20 μA	4.5	4.4			4.4		4.4		V
V _{OH}	HIgh-level output voltage	V _{OH} = – 4 mA	4.5	3.98			3.84		3.7		V
	Low-level output voltage	V _{OL} = 20 μA	4.5			0.1		0.1		0.1	V
V _{OL}	Low-level output voltage	V _{OL} = 4 mA	4.5			0.26		0.33		0.4	V
1	Input leakage current	$V_{I} = V_{CC}$ or GND	5.5			±0.1		±1		±1	μA
сс	Supply current	$V_{I} = V_{CC}$ or GND	5.5			8		80		160	μA
ΔI _{CC} (1)		One of A0 - A2 and \overline{LE} inputs held at V _{CC} – 2.1	4.5 to 5.5		100	540		675		735	
	Additional supply current per input pin	D input held at $V_{CC} - 2.1$	4.5 to 5.5		100	432		540		588	μA
		$\overline{\text{MR}}$ input held at V_{CC} – 2.1	4.5 to 5.5		100	270		337.5		367.5	

(1) $V_I = V_{IH}$ or V_{IL} , unless otherwise noted.



5.5 Prerequisite for Switching Characteristics

	PARAMETER	V 00		25°C	-40°C to 85°C		-55°	C to 125°0	
	PARAMETER	V _{cc} (V)	MIN	TYP MAX	MIN	TYP MAX	MIN	TYP N	
НС ТҮР	PES	I							
		2	70		90		105		
t _{WL}	Pulse Width \overline{G}	4.5	14		18		21		ns
		5	12		15		18		
		2	70		90		105		
t _{WL}	CLR	4.5	14		18		21		ns
		6	12		15		18		
t _{su}	Setup time	2	80		100		120		
	D to \overline{G}	4.5	16		20		24		ns
	S to \overline{G}	6	14		17		20		
	Hold time	2	0		0		0		
t _H	D to \overline{G}	4.5	0		0		0		ns
	S to \overline{G}	6	0		0		0		
НСТ Т	(PES								
t _{WL}	Pulse width G CLR	4.5	18		23		27		ns
t _{SU}	Setup Time D to G S to G	4.5	17		21		26		ns
t _H	Hold Time D to G S to G	4.5	0		0		0		pF



5.6 Switching Characteristics⁽²⁾

 C_L = 50pF, Input t_t = 6ns

PARAMETER		V 00		25°C		-40°C to 85°C	-55°C to 125°C	UNIT
	FARAMETER	V _{CC} (V)	MIN	TYP	MAX	MIN MAX	MIN MAX	UNIT
НС ТҮ	'PES							
		2			185	230	280	
	D to Q	4.5		15 ⁽¹⁾	37	46	56	ns
		6			31	39	48	
		2			170	215	255	
	G to Q	4.5		14 ⁽¹⁾	34	43	51	ns
+ .		6			29	37	43	
t _{pd}		2			185	230	280	
	S to Q	4.5		15 ⁽¹⁾	37	46	56	ns
		6			31	39	48	
	CLR to Q	2			155	195	235	
		4.5		13 ⁽¹⁾	31	39	47	ns
	-	6			26	33	40	
		2			75	95	110	
tt	Output transition time	4.5			15	19	22	ns
	-	6			13	16	19	
C _{pd}	Power dissipation Capacitance ⁽¹⁾	5		21 ⁽¹⁾				pF
Ci	Input capacitance		10		10	10	10	pF
нст т	YPES						· · · · · ·	
	D to Q	4.5		16 ⁽¹⁾	39	49	59	ns
	G to Q	4.5		16 ⁽¹⁾	38	48	57	ns
t _{pd}	S to Q	4.5		17 ⁽¹⁾	41	51	61	ns
	CLR to Q	4.5		16 ⁽¹⁾	39	49	59	pF
C _{pd}	Power dissipaction Capacitance ⁽¹⁾	5		22 ⁽¹⁾				pF
Ci	Input Capacitance		10		10	10	10	pF
tt	Output transition time	4.5			15	19	22	ns

(1) $C_L = 15 pF$ and $V_{CC} = 5 V$. (2) For details on CMOS power calculation see, SCAA053B.

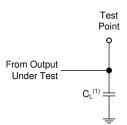


6 Parameter Measurement Information

Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, Z_O = 50 Ω , t_t < 6 ns.

For clock inputs, f_{max} is measured when the input duty cycle is 50%.

The outputs are measured one at a time with one input transition per measurement.



(1) C_L includes probe and test-fixture capacitance.



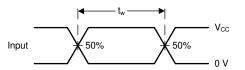


Figure 6-2. Voltage Waveforms, Standard CMOS Inputs Pulse Duration

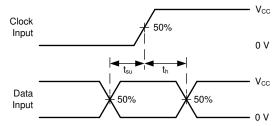
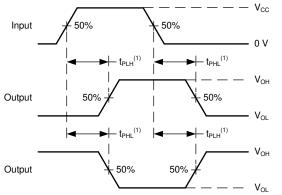


Figure 6-3. Voltage Waveforms, Standard CMOS Inputs Setup and Hold Times





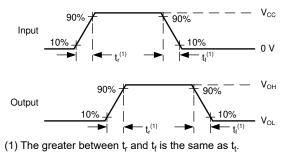
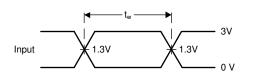


Figure 6-5. Voltage Waveforms, Input and Output Transition Times for Standard CMOS Input Devices







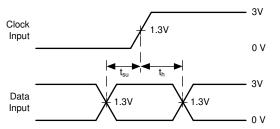
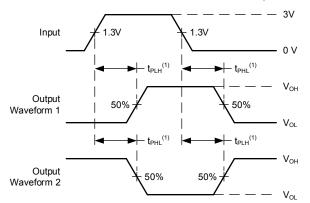


Figure 6-7. Voltage Waveforms, TTL-Compatible CMOS Inputs Setup and Hold Times



(1) The greater between t_{PLH} and t_{PHL} is the same as $t_{\mathsf{pd}}.$

Figure 6-8. Voltage Waveforms, TTL-Compatible CMOS Inputs Propagation Delays



7 Detailed Description

7.1 Overview

The CDx4HC(T)259 8-bit addressable latches are designed for general-purpose storage applications in digital systems. Specific uses include working registers, serial-holding registers, and active-high decoders or demultiplexers. They are multifunctional devices capable of storing single-line data in eight addressable latches and being a 1-of-8 decoder or demultiplexer with active-high outputs.

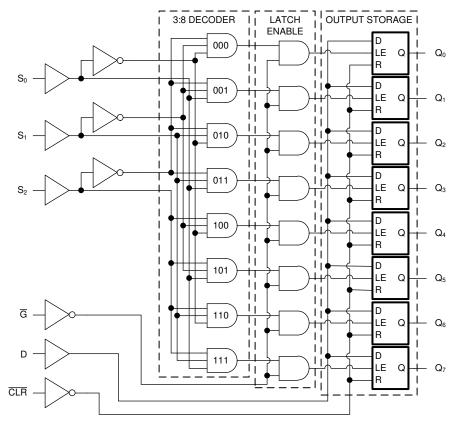
Four distinct modes of operation are selectable by controlling the clear ($\overline{\text{CLR}}$) and enable ($\overline{\text{G}}$) inputs:

- Addressable-latch mode: CLR = HIGH; G = LOW
 - Data at the data-in terminal is written into the addressed latch

- The addressed latch follows the data input, with all unaddressed latches remaining in their previous states

- Memory mode: CLR = HIGH; G = HIGH
 - All latches remain in their previous states and are unaffected by the data or address inputs
 - To eliminate the possibility of entering erroneous data in the latches, G should be held high (inactive) while the address lines are changing
- 1-of-8 decoding or demultiplexing mode: $\overline{\text{CLR}}$ = LOW; $\overline{\text{G}}$ = LOW
 - The addressed output follows the level of the D input with all other outputs low
- Clear mode: $\overline{\text{CLR}}$ = LOW; $\overline{\text{G}}$ = HIGH
 - All outputs are low and unaffected by the address and data inputs

7.2 Functional Block Diagram





7.3 Device Functional Modes

The Function Tableand Latch Selection Table below list the functional modes of the CDx4HC(T)259.

1										
	INPUTS ⁽¹⁾		OUTPUT OF	EACH OTHER						
	CLR	G	ADDRESSED LATCH ⁽²⁾	OUTPUT ⁽²⁾	FUNCTION					
	Н	L	D	Q _{iO}	Addressable latch					
	Н	Н	Q _{iO}	Q _{iO}	Memory					
	L	L	D	L	8-line demultiplexer					
	L	Н	L	L	Clear					

Table 7-1. Function Table

(1) H = High voltage level, L = Low voltage level

(2) Q_{iO} = Previous output state of selected latch, D = Data input logic value

SELECT INPUT	SELECT INPUTS ⁽¹⁾								
S2	S1	S0	ADDRESSED						
L	L	L	0						
L	L	Н	1						
L	Н	L	2						
L	Н	Н	3						
Н	L	L	4						
Н	L	Н	5						
н	Н	L	6						
Н	Н	Н	7						

Table 7-2. Latch Selection Table

(1) H = High Voltage Level, L = Low Voltage Level



8 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the *Recommended Operating Conditions*. Each V_{CC} terminal should have a good bypass capacitor to prevent power disturbance. A 0.1- μ F capacitor is recommended for this device. It is acceptable to parallel multiple bypass caps to reject different frequencies of noise. The 0.1- μ F and 1- μ F capacitors are commonly used in parallel. The bypass capacitor should be installed as close to the power terminal as possible for best results.

9 Layout

9.1 Layout Guidelines

When using multiple-input and multiple-channel logic devices inputs must not ever be left floating. In many cases, functions or parts of functions of digital logic devices are unused; for example, when only two inputs of a triple-input AND gate are used or only 3 of the 4 buffer gates are used. Such unused input pins must not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. All unused inputs of digital logic devices must be connected to a logic high or logic low voltage, as defined by the input voltage specifications, to prevent them from floating. The logic level that must be applied to any particular unused input depends on the function of the device. Generally, the inputs are tied to GND or V_{CC} , whichever makes more sense for the logic function or is more convenient.



10 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

10.1 Documentation Support

10.1.1 Related Documentation

10.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

10.3 Support Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

10.4 Trademarks

TI E2E[™] is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

10.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

10.6 Glossary

TI Glossary This glossary lists and explains terms, acronyms, and definitions.

11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
5962-8985201EA	Active	Production	CDIP (J) 16	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-8985201EA CD54HCT259F3A
CD54HC259F3A	Active	Production	CDIP (J) 16	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	8551901EA CD54HC259F3A
CD54HC259F3A.A	Active	Production	CDIP (J) 16	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	8551901EA CD54HC259F3A
CD54HCT259F3A	Active	Production	CDIP (J) 16	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-8985201EA CD54HCT259F3A
CD54HCT259F3A.A	Active	Production	CDIP (J) 16	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-8985201EA CD54HCT259F3A
CD74HC259E	Active	Production	PDIP (N) 16	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	-55 to 125	CD74HC259E
CD74HC259E.A	Active	Production	PDIP (N) 16	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	-55 to 125	CD74HC259E
CD74HC259M	Obsolete	Production	SOIC (D) 16	-	-	Call TI	Call TI	-55 to 125	HC259M
CD74HC259M96	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU SN	Level-1-260C-UNLIM	-55 to 125	HC259M
CD74HC259M96.A	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC259M
CD74HC259M96G4	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC259M
CD74HC259M96G4.A	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC259M
CD74HC259MT	Obsolete	Production	SOIC (D) 16	-	-	Call TI	Call TI	-55 to 125	HC259M
CD74HCT259E	Active	Production	PDIP (N) 16	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	-55 to 125	CD74HCT259E
CD74HCT259E.A	Active	Production	PDIP (N) 16	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	-55 to 125	CD74HCT259E
CD74HCT259E.B	Active	Production	PDIP (N) 16	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	-55 to 125	CD74HCT259E
CD74HCT259EE4	Active	Production	PDIP (N) 16	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	-55 to 125	CD74HCT259E
CD74HCT259M	Obsolete	Production	SOIC (D) 16	-	-	Call TI	Call TI	-55 to 125	HCT259M
CD74HCT259M96	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU SN	Level-1-260C-UNLIM	-55 to 125	HCT259M
CD74HCT259M96.A	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT259M
CD74HCT259M96.B	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT259M
CD74HCT259M96G4	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT259M
CD74HCT259M96G4.A	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT259M
CD74HCT259MT	Obsolete	Production	SOIC (D) 16	-	-	Call TI	Call TI	-55 to 125	HCT259M

⁽¹⁾ **Status:** For more details on status, see our product life cycle.



www.ti.com

12-Aug-2025

⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF CD54HC259, CD54HCT259, CD74HC259, CD74HCT259 :

• Catalog : CD74HC259, CD74HCT259

• Military : CD54HC259, CD54HCT259

NOTE: Qualified Version Definitions:

• Catalog - TI's standard catalog product

• Military - QML certified for Military and Defense Applications



Texas

STRUMENTS

TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	-	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD74HC259M96G4	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
CD74HCT259M96G4	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1



www.ti.com

PACKAGE MATERIALS INFORMATION

25-Jul-2025



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD74HC259M96G4	SOIC	D	16	2500	353.0	353.0	32.0
CD74HCT259M96G4	SOIC	D	16	2500	353.0	353.0	32.0

TEXAS INSTRUMENTS

www.ti.com

25-Jul-2025

TUBE



- B - Alignment groove width

*All d	limensions	are	nominal	

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	Τ (μm)	B (mm)
CD74HC259E	N	PDIP	16	25	506	13.97	11230	4.32
CD74HC259E	N	PDIP	16	25	506	13.97	11230	4.32
CD74HC259E.A	N	PDIP	16	25	506	13.97	11230	4.32
CD74HC259E.A	N	PDIP	16	25	506	13.97	11230	4.32
CD74HCT259E	N	PDIP	16	25	506	13.97	11230	4.32
CD74HCT259E	N	PDIP	16	25	506	13.97	11230	4.32
CD74HCT259E.A	N	PDIP	16	25	506	13.97	11230	4.32
CD74HCT259E.A	N	PDIP	16	25	506	13.97	11230	4.32
CD74HCT259E.B	N	PDIP	16	25	506	13.97	11230	4.32
CD74HCT259E.B	N	PDIP	16	25	506	13.97	11230	4.32
CD74HCT259EE4	N	PDIP	16	25	506	13.97	11230	4.32
CD74HCT259EE4	N	PDIP	16	25	506	13.97	11230	4.32

J (R-GDIP-T**) 14 LEADS SHOWN

CERAMIC DUAL IN-LINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- \triangle The 20 pin end lead shoulder width is a vendor option, either half or full width.



D (R-PDSO-G16)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATA SHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.

TI objects to and rejects any additional or different terms you may have proposed.

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2025, Texas Instruments Incorporated